

Search Notes**Application/Control No.**

10/517,318

Examiner

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Applicant(s)/Patent under Reexamination

NAITO ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
425	542	3/18/2007	EL
425	416	3/18/2007	EL
83	22	3/18/2007	EL
83	24	3/18/2007	EL
83	99	3/18/2007	EL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search	3/18/2007	EL

INTERFERENCE SEARCHED

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